

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/749,968	SMITH, JASON L.	
Examiner	Art Unit	
Craig M. Schneider	3752	

SEARCHED					
Class	Subclass	Date	Examiner		
137	636.2	8/24/2005	смѕ		
137	636.3	8/24/2005	CMS		
137	636	8/24/2005	CMS		
137	377	8/24/2005	смѕ		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NO (INCLUDING SEARC)
	DATE	EXMR
Inventor Search in Palm (Smith, Jason)	8/24/2005	CMS
Search from J. Rivell	8/24/2005	смѕ